


<b>Search Notes</b>  	<b>Application/Control No.</b>  10582006	<b>Applicant(s)/Patent Under Reexamination</b>  LAI ET AL.
	<b>Examiner</b>  Mary E Mosher, Ph.D.	<b>Art Unit</b>  1648

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST USPat PGPub EPO JPO Derwent, see printout	9/11/08	MM
SEQ 3,5,7,11,13,15, see SCORE	8/8/08	STIC
Dialog 155, 357, see printouts	9/11/08	MM
inventor search	"	"
EAST update, see printout	2/19/09	"
DENV-4 strains from different geographical origins	6/1/09	"

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	seq 1, 3, 5, 7, 9, 11, 13, 15, see SCORE	5/29/09	STIC
	EAST, see printout	6/1/09	MM

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